Table 1

base film		SIN			SINO	
sample	S i N(a)	S i N(b)	S i N(c)	S i NO(a)	S i NO(b)	S i NO(c)
hydrofluoric acid treatment (120sec)	0			О		
hydro washing (60sec)		0			0	
hydrofluoric acid treatment (120sec)		0			0	
water washing		0			0	
heat-treatment (150°C, 3min)		0			0	
applying a positive photosensitive acrylic resin		0			0	
washing periphery of sample		0			0	
exposure		0			0	
development		0			0	
water contact angle (degree)(after deposition)		50			44	
wettability of the positive photosensitive acrylic resin (after applying)	0	0	0	0	0	0
adhesiveness of patterns (after development)	0	0	0	×	×	0

Table 2

base film		SION			SiO2	
sample	S i ON(a)	(q)NOIS	S i ON(c)	S i O ₂ (a)	S i O ₂ (b)	S i O ₂ (c)
hydrofluoric acid treatment (120sec)	О			0		
hydro washing (60sec)		0			0	
hydrofluoric acid treatment (120sec)		0			0	
water washing		0			0	
heat-treatment (150°C, 3min)		Ο			0	
applying a positive photosensitive acrylic resin		0			0	
washing periphery of sample		0			0	
exposure		0			0	
development		0			0	
water contact angle (degree)(after deposition)		24			15	
wettability of the positive photosensitive acrylic resin (after applying)	0	0	0	0	0	0
adhesiveness of patterns (after development)	×	×	×	×	×	×

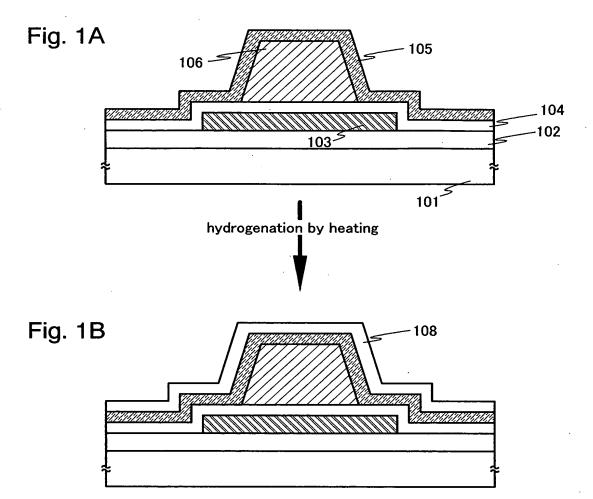


Fig. 1C

